

INTEGRATION OF MULTILEVEL SUPERCONDUCTING BURIED WIRING LAYERS WITH TRANSITION-EDGE SENSOR DETECTORS FOR LARGE SCALE ARRAYS

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SECOND ITERATION: LYNX PROTOTYPE





FIRST ITERATION CHARACTERIZATION

Intrinsic T_C of Mo/Au bilayer was about 200 mK. Increased Tc due to the Nb patch was observed, which is consistent with the SOLAR-E results. The experiment demonstrated that the series via resistance was about 20 m Ω for Design 1, and 7 m Ω for Design 2. The result is consistent with

The R(T) curves agreed for 12 µm devices with different via designs when both possessed the Nb patch, which short-circuited the via resistance. • Zero-bias measurement using SQUID electronics shows elevated critical temperature for all sizes – moreso for 7 µm TES – with no discernible

FIRST ITERATION X-RAY TESTING RESULTS

Size (µm)	$R_{n}(m\Omega)$	T _C (mK)	Nb Patch
7		700	
7	14	730	Y
8		470	
8	20	500	Ν
9	20	500	Ν
9	20	520	N
12	14	500	Y
12	14	500	Y

Low-Excitation Measurement

• Using an 8 µm TES with via Design 1, we report an energy resolution of 1.12 eV for Al K α and 1.93 eV for Mn K α , as

The initial results indicate that a detector with a critical temperature of 65 mK utilizing a 1 micron thick absorber would demonstrate a desirable energy resolution of 0.2 eV at 1 keV. X-ray testing of Lynx prototype devices (from the second iteration) is underway.